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Magnetic Shielding for Electromagnetic Compatibility Applications

Guest Editors:

Dr. Gang Zhang

School of Electrical Engineering and Automation, Harbin Institute of Technology, Harbin 150001, China

Dr. Alistair Duffy

School of Engineering and Sustainable Development, De Montfort University, The Gateway, Leicester LE1 9BH, UK

Deadline for manuscript submissions:

closed (31 May 2024)

Message from the Guest Editors

There are many research fronts, including:

- Optimization of shield designs (including weight reduction).
- Novel materials and material characterization (including metamaterial research).
- Active magnetic shielding.
- Application assessments and performance verification.
- Measurement techniques.
- Lifecycle assessment.

The objective of this Special Issue is to collate leading research on the subject to act as a reference for emerging applications and further contemporary research. Hence, we are seeking papers related (but not limited) to these research fronts and applications. Original research articles and reviews are welcome.

We look forward to receiving your contributions.

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Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

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